

Search Notes

Application/Control No.

10/663,755

Examiner

Hiep Nguyen

Applicant(s)/Patent under
Reexamination

SMITH, STERLING

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST See attachment	08.28.06	HA